

承 認 書 SPECIFICATION FOR APPROVAL

客戶名稱 CUSTOMER	:			
客戶料號 CUSTOMER'S P/N	:			
料號 PART NUMBER	: <u>WAN3216F2</u>	245H05		>
規格 DESCRIPTION	: Chip Antenna	3216 M-Ant 2.45G	Type H05	
版本 VERSION	: <u>V1.2</u>			
日期 ISSUE DATE	: 2023/06/13		\$\frac{1}{1}	
	CU	客戶承認 JSTOMER APPROV	ED	
		K-X		
		工 程 部		
A	承認 APPROVAL	R&D CENTER 確認 CHECKED	製作 DRAWN	
2	Ray	Tennyson	Snow	



萬誠科技股份有限公司

112台北市北投區立功街 151號 1樓

電話: (02) 2898-2220 傳真: (02) 2898-5055

OneWave Electronic Co., Ltd.

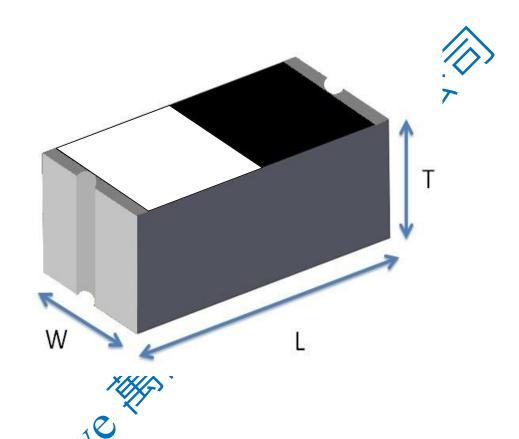
1F, No. 151, Li Gong Street, Beitou District, Taipei City 112, Taiwan

TEL: +886 2 2898-2220 FAX: +886 2 2898-5055



3216 Chip antenna

For Bluetooth / WLAN Applications



P/N: WAN3216F245H05

	Dimension (mm)
L	3.23 ± 0.20
W	1.66 ± 0.20
Т	1.23 ± 0.20



Part Number Information

A	Product Series	Antenna					
В	Dimension L x W	3.2X1.6mm (+-0.2mm)					
C	Material	High K material					
D	Working Frequency	2.4 ~ 2.5GHz					
E	Feeding mode	Monopole & Single Feeding					
F	Antenna type Type = 05						
ectric	cal Specification						
Specification							
	Part Number	WAN3216F245H05					

1. Electrical Specification

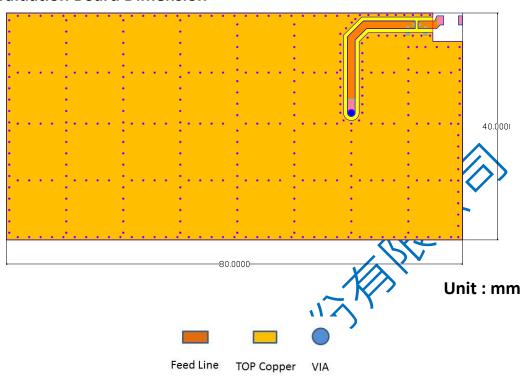
Specification						
Part Number	WAN3216F245H05					
Central Frequency	2450	MHz				
Bandwidth	100 (Min.)	MHz				
Return Loss	-6.5 (Max)	dB				
Peak Gain	2.41	dBi				
Impedance	50	Ohm				
Operating Temperature	-40~+110	$^{\circ}$ C				
Maximum Rower	4	W				
Resistance to Soldering Heats	10 (@ 260℃)	sec.				
Polarization	Linear					
Azimuth Beamwidth	Omni-directional					
Termination	Cu / Sn (Leadless)					

Remark: Bandwidth & Peak Gain was measured under evaluation board of next page



2. Recommended PCB Pattern

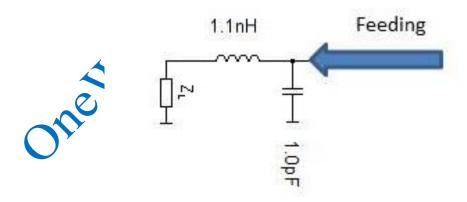
Evaluation Board Dimension



Suggested Matching Circuit

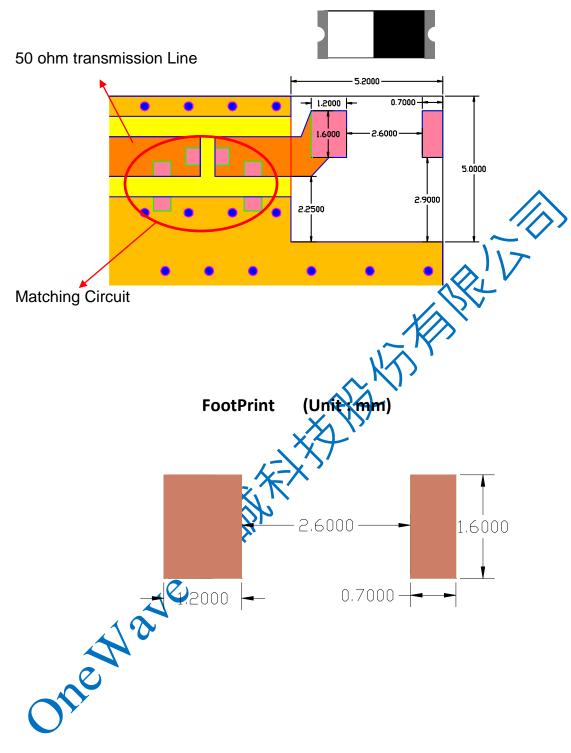
重要資訊:

匹配元件建議使用為達度高的電威±0.1~0.3nH、電容±0.1pF





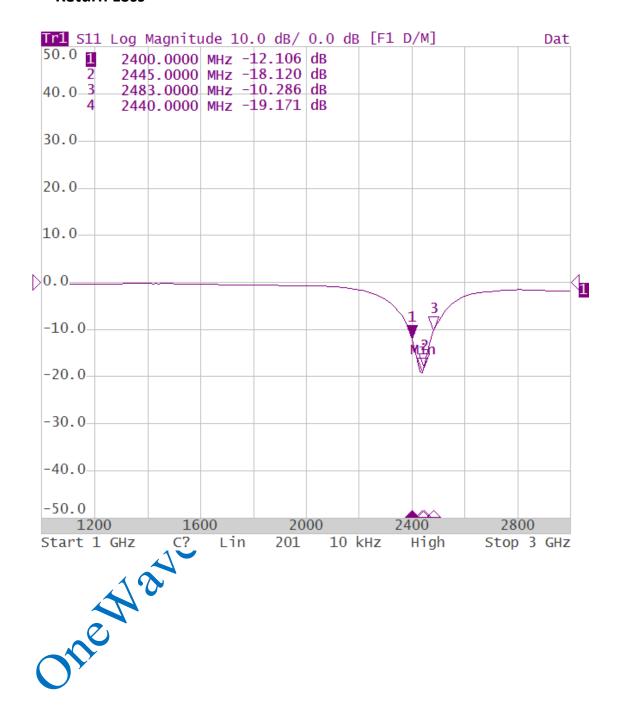
Layout Dimensions in Clearance area(Size=5.2*5.0mm)





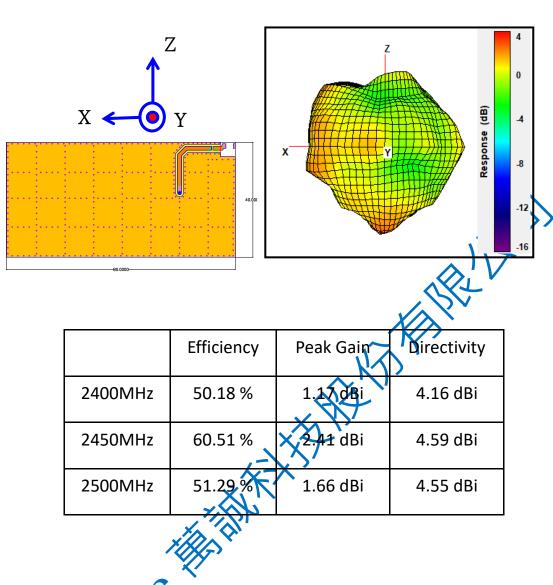
3. Measurement Results

Return Loss

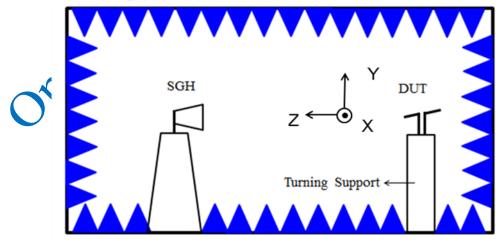




Radiation Pattern



Chamber Coordinate System





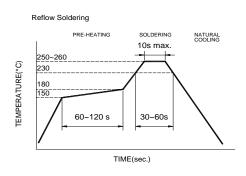
4.Reliability and Test Condictions

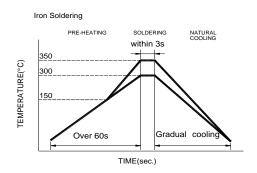
ITEM	REQUIREMENTS	TEST CONDITION			
Solderability	Wetting shall exceed 90% coverage	Pre-heating temperature:150°C /60sec.			
	2. No visible mechanical damage	Solder temperature:230±5°C			
	TEMP (°C)	Duration:4±1sec.			
	230°C 4±1 sec.	Solder:Sn-Ag3.0-Cu0.5 Flux for lead free: rosin			
	230°C 4±1 sec.	Tiux for lead free. Tosiff			
	150℃				
	1300				
	60sec				
Solder heat	No visible mechanical damage	Pre-heating temperature:150°C /60sec.			
Resistance	2. Central Freq. change :within ± 6%	Solder temperature:260±5℃			
	TEMP (℃)	Duration:10±0.5sec.			
	10+0.5 coc	Solder:Sn-Ag3.0-Cu0.5			
	260°C 10 <u>1</u> 0.3 sec.	Flux for lead free: rosin			
	150°C	\wedge \vee			
	1000				
	60sec \				
Component Adhesion	No visible mechanical damage	The device should be reflow soldered(280±5° for 10sec.) to a tinned			
(Push test)		copper substrate A dynometer force			
(11 11)		gauge should be applied the side of the			
		component. The device must with-ST-F			
	· M	0.5 Kg without failure of the termination attached to component.			
Component	No visible mechanical damage	Insert 10cm wire into the remaining open			
Adhesion		eye bend ,the ends of even wire lengths			
(Pull test)	(- x)	upward and wind together.			
(Terminal shall not be remarkably			
		damaged.			
Thermal shock	No visible mechanical damage	+110°C=>30±3min			
	2. Central Freq. change :within ±6%	-40°C=>30±3min			
	Phase Temperature(°C) Time(min)	Test cycle:10 cycles			
	1 +110±5°C 30±3	The chip shall be stabilized at normal			
	D = 1M(4)-1	condition for 2~3 hours before			
	2 Room Within Temperature 3sec	measuring.			
	3 -40±2°C 30±3				
	4 Room Within				
	Temperature 3sec				
Desistanta	7)	Temperature: +110±5°ℂ			
Resistance to High	1. No visible mechanical damage	Duration: 1000±12hrs			
Temperature	2. Central Freq. change :within ±6%	The chip shall be stabilized at normal			
remperature	3. No disconnection or short circuit.	condition for 2~3 hours before			
		measuring.			
Resistance to	No visible mechanical damage	Temperature:-40±5°C			
Low	2. Central Freq. change :within ±6%	Duration: 1000±12hrs			
Temperature	No disconnection or short circuit.	The chip shall be stabilized at normal			
	3. 140 disconfication of short circuit.	condition for 2~3 hours before			
		measuring.			
Humidity	No visible mechanical damage	Temperature: 40±2°C			
	2. Central Freq. change :within ±6%	Humidity: 90% to 95% RH Duration: 1000±12hrs			
	3. No disconnection or short circuit.				
		The chip shall be stabilized at normal			
		condition for 2~3 hours before			
		measuring.			



5. Soldering and Mounting

Mildly activated rosin fluxes are preferred. The minimum amount of solder can lead to damage from the stresses caused by the difference in coefficients of expansion between solder, chip and substrate. The terminations are suitable for all wave and re-flow soldering systems. If hand soldering cannot be avoided, the preferred technique is the utilization of hot air soldering tools.





Recommended temperature profiles for re-flow soldering in Figure 1.

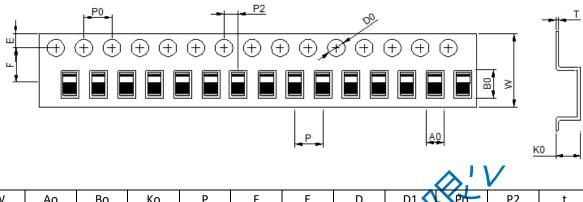
Products attachment with a soldering iron is discouraged due to the inherent process control limitations. In the event that a soldering iron must be employed the following precautions are recommended.

- Preheat circuit and products to 150°C
- Never contact the ceramic with the iron tip
- Use a 20 wattsoldering iron with tip diameter of 1.0mm
- 280° tip temperature (max)
- 1.0mm tip diameter (max)
- Limit soldering time to 3 sec.



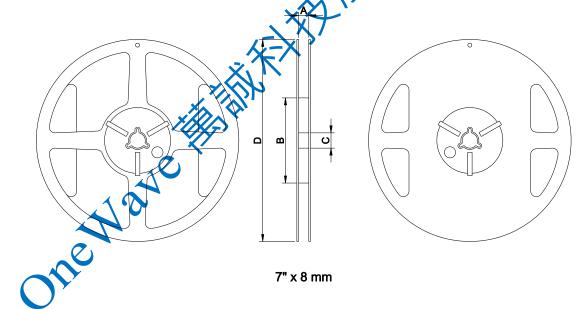
6.Packaging Information

♦ Tape Specification:



W	Ao	Во	Ko	Р	F	E	D	D1 ()	Po	P2	t
8.0	1.80	3.51	1.59	4.00	3.50	1.75	1.50	0.00	4.00	2.00	0.25
±0.30	±0.05	±0.10	±0.10	±0.05	±0.05	±0.10	±0.10	±0.10	±0.10	±0.05	±0.05

• Reel Specification: (7", Φ180 mm)



Tape Width(mm)	A(mm)	B(mm)	C(mm)	D(mm)	Chip/Reel(pcs)
8	9.0±0.5	60±2	13.5±0.5	178±2	3000



7. Storage and Transportation Information

Storage Conditions

To maintain the solderability of terminal electrodes:

- 1. Temperature and humidity conditions: -10~ 40°C and 30~70% RH.
- 2. Recommended products should be used within 6 months from the time of delivery.
- 3. The packaging material should be kept where no chlorine or sulfur exists in the air.

Transportation Conditions

The Nave Health

- Products should be handled with care to avoid damage or contamination from perspiration and skin oils.
- 2. The use of tweezers or vacuum pick up is strongly recommended for individual components.
- 3. Bulk handling should ensure that abrasion and mechanical shock are minimized.